## Application/Control No. Applicant(s)/Patent Under Reexamination 10/765,496 AHMED ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 MICHAEL Y. WON 2155 **U.S. PATENT DOCUMENTS**

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<sup>\*</sup>A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.